Application/Control No. Applicant(s)/Patent Under Reexamination 10/697,161 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2681 Pierre-Louis Desir **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 06-2004 379/210.01 US-2004/0120494 Jiang et al. Α В US-6,574,335 06-2003 Kalmanek et al. 379/386 С US-D US-Ε US-US-F US-G Н US-1 US-US-Κ US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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